TSA Air Cargo Screening Technology List (ACSTL)

Version 12.6

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Revision History

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| 11.3 | 20200907 |
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| 11.1 | 20200106 |
| 11.0 | 20191028 |

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1 Introduction

1.1 Document Purpose

The Air Cargo Screening Technology List (ACSTL) serves as TSA's official guide for regulated parties to use when procuring screening devices and associated trace consumables in accordance with TSA approved security programs. Any technology purchased from this list must be utilized in accordance with measures outlined in a screener's Standard Security Program. This list does not apply to devices owned by TSA or devices used in TSA-sponsored tests or test beds. Reference the SSI version of the ACSTL to determine approved and qualified software versions. This information is not contained in the Non-SSI version of the ACSTL.

1.2 Document Format

The document is arranged by Technology Qualification Group as follows: (1) Visual Image (VI) Devices, formerly referred to as the Non-Computed Tomography (Non-CT) Transmission X-ray Devices, (2) Explosive Trace Detection (ETD) Devices, (3) Metal Detectors (MD), formerly referred to as the Electronic Metal Detection (EMD) Devices, (4) Explosive Detection Systems (EDS), and (5) Carbon Dioxide (CO2) Monitors. Under each Technology Qualification Group are three sections: A Qualified Technology section, an Approved Technology section, and a Grandfathered Technology section. The Qualified Technology section specifies devices, by technology, which have undergone a formal TSA-sponsored test process and are deemed qualified for screening operations. When procuring a device from the ACSTL, regulated parties are encouraged to select a device from the Qualified Technology section. The Approved Technology section specifies devices, by technology, which have been conditionally approved for screening operations and are currently undergoing or are scheduled for field-test activities. These devices have up to 36 months from the date added to the Approved Technology section to successfully pass TSA's suitability based field-test activities. If a device is unable to pass field-test activities within the prescribed 36 months, it will be removed from the Approved Technology section. Due to this fact, regulated parties who procure a device from the Approved Technology section do so at their own risk. Additional technologies may be added to the Approved Technology section at TSA's discretion. The Grandfathered Technology section specifies devices, by technology, which are currently qualified to screen cargo but have a stated expiration date. This allows regulated parties who are using the grandfathered technology an opportunity to gradually phase out the device and transition to devices listed in the Qualified or Approved sections. Due to this fact, regulated parties should not purchase devices from this section; rather, they should reference the Qualified or Approved sections for their procurement needs.

1.3 Disclaimer

The Approved Technology section reflects devices that have successfully passed Stage I of the qualification testing process. TSA reserves the right to remove any device from this section that fails Stage II test activities. The Grandfathered Technology section reflects devices that are currently qualified to screen cargo but have a stated expiration date. TSA also reserves the right to remove

devices from the Approved or Qualified section or revise an expiration date for Grandfathered devices due to a device's inability to meet more stringent performance parameters associated with emerging threats. Should such a situation occur, TSA will issue specific guidance on how previously purchased devices may be used.

1.4 Device Configuration

Top Assembly Part Number and Required Software Version indicate the only qualified configurations for each Device Model Number. Models with different part numbers or software versions are not considered qualified screening devices. Reference the SSI version of the ACSTL to determine approved and qualified software versions. This information is not contained in the Non-SSI version of the ACSTL.

1.5 Operating Environment

Devices listed within the ACSTL are intended to be operated under controlled temperature and humidity conditions. Add-on components and kits may be available from vendors to extend operational temperature and humidity ranges.

1.6 Manufacturer Contact Information

| Company | Address | Point of Contact | Phone Number | E-mail |
|------------------------------------|---|---------------------|------------------|--|
| 1 st Detect Corporation | 2105 Donley Drive, Suite 100 Austin, TX 78758 | Eric Wallis | 512-485-9537 | ewallis@astrotechcorp.com |
| Armstrong Monitoring | 215 Colonnade Road South Ottawa, ON K2E 7K3 Canada | Scott Bissett | 800-465-5777 | SBissett@armstrongmonitoring.com |
| Astrophysics, Inc. | 21481 Ferrero Parkway City of Industry, CA 91789 | Yaron Yezersky | 909-598-5488 | yyezersky@astrophysicsinc.com |
| Bruker Detection Corporation | 40 Manning Road Billerica, MA 01821 | Anthony Castellanos | 978-729-2982 | Anthony.Castellanos@BrukerDetection.US |
| Bruker Detection Corporation | 40 Manning Road Billerica, MA 01821 | Mirela Popa | 980-392-9492 | Mirela.Popa@BrukerDetection.US |
| CEIA USA | 9155 Dutton Drive Twinsburg Ohio 44087 | Luca Cacioli | 330-217-7995 | LCacioli@ceia-usa.com |
| Gilardoni S.p.A. | Via Arturo Gilardoni 1 Mandello del Lario 23826 (LC), Italy | Luca Ghislanzoni | 0039-0341-705218 | lg@gilardoni.it |
| InstroTek, Inc. | 1 Triangle Drive, PO 13944 Research Triangle Park, NC 27709 | Ali Regimand | 919-875-8371 | ARegimand@instrotek.com |

| Company | Address | Point of Contact | Phone Number | E-mail |
|-------------------------|---|---------------------|------------------|-------------------------------------|
| Leidos | One Radcliff Road Tewksbury, MA 01876 | Lorie Halitzka | 424-344-1552 | Lorie.a.halitzka@leidos.com |
| Mettler-Toledo Safeline | 6005 Benjamin Road Tampa, FL 33634 | Chris Acierno | 813-889-9500 | Chris.Acierno@mt.com |
| Rapiscan Systems | 2900 Crystal Drive, Suite 910 Arlington, VA 22202 | Iven King | 540-300-0412 | IKing@osi-systems.com |
| Smiths Detection, Inc. | 2202 Lakeside Blvd Edgewood, MD 21040 | Philip Tackett | 410-652-3392 | Philip.Tackett@Smiths-Detection.com |
| VMI Security | Av. Hum, 55-Distrito Industrial Genesco Aparecido De Oliveira, Lagoa Santa – MG 33400-000, Brazil | Lazaro Borges Silva | +55 31 3622-0470 | Lazaro.silva@vmis.com.br |
| X-Ray Center (XRC) | Beylikduzu OSB Mahallesi, 10 Cadde, NO: 14 Beylikduzu Istanbul, 34524 Turkey | Kami Havluciyan | +90-212-665-1328 | kami@x-raycenter.com |

1.7 Updates in This Version

| Page | Section | Change |
|-------|---------------------------------------|---|
| 10-14 | 2.1 Qualified Visual Image Technology | Addition of new TAPN for Astrophysics XIS-6545DVS per ECP 0048. Addition of new software version for Leidos PX10.10 per 24-AC-AXE008852. Addition of new software version for Rapiscan 920DX, 927DX, and 928DX per ECP-AC-074. Administrative correction to Rapiscan 632DV software version to remove extra ".". Addition of qualified VMI 6040DV, 100100HDV, and 180180DV (320kV) per ACSQT. Addition of new software version for XRC 180-180DV (320kV) per XRC CR032. Administrative change - correction to XRC 100-100HCDV software version. |
| 15 | 2.2 Approved Visual Image Technology | Removal of VMI 6040DV, 100100HDV, and 180180DV (320kV) due to qualification. |
| 18 | 3.1 Qualified ETD Technology | Update of Note 1. Addition of new software version for Smiths IONSCAN600 per CN103317. |
| 19 | 3.2 Approved ETD Technology | Update of Note 1. |
| 20 | 3.3 Grandfathered ETD Technology | Update of Note 1. |
| 28 | 5.2 Approved EDS Technology | Addition of new software version for Smiths HS 10080 XCT per CN103181. |

2 Visual Image Devices

Technology Description: Fixed projection Visual Image inspection devices that display digitized transmission radiographic images of an object under inspection following an interrogation.

Technology Classification: This technology is classified by material discrimination capability, number of views, and capacity.

Material discrimination capability: Classification groups are "Yes (Y)" and "No (N)." "Yes" indicates devices that are capable of enabling visual differentiation between types of materials detected, e.g., nylon vs explosives vs PVS under steel. "No" indicates devices that do not discriminate between different materials.

Number of views: Classification groups are single view (grandfathered), dual view, and multi view. Devices may display images scanned from one, two, or multiple perspectives. Regardless of a device's manual or assisted-detection capability, the operator must view and interpret one or more images of each object under inspection as dictated by the applicable security program.

Capacity designation: Device capacity groups are defined in the table below. The capacity listing is for testing and informational purposes only.

Visual Image Device Capacity Designations

| ID | Description |
|----|---|
| А | Small Aperture – Can accommodate screening of air cargo with an item size of at least 49 cm (19.3 in) wide by 38 cm (15 in) high by 91 cm (35.8 in) long and 50 kg (110.2 lbs.) in weight and up to 80 cm (31.5 in) wide by 60 cm (23.6 in) high by 120 cm (47.2 in) long and 100 kg (220.5 lbs.) in weight. |
| В | Medium Aperture – Can accommodate screening of air cargo with at item size of at least 80 cm (31.5 in) wide by 60 cm (23.6 in) high by 120 cm (47.2 in) long and 100 kg (220.5 lbs.) in weight and up to 122 cm (48 in) wide by 153 cm (60.2 in) high by 122 cm (48 in) long and 1,000 kg (2,205 lbs.) in weight. |
| С | Large Aperture – Can accommodate screening of air cargo with an item size of at least 122 cm (48 in) wide by 153 cm (60.2 in) high by 122 cm (48 in) long and 1,000 kg (2,205 lbs.) in weight. |

2.1 Qualified Visual Image Technology

The Qualified Technology section specifies devices that have undergone a formal TSA-sponsored test process and are deemed qualified for screening operations. When procuring a device from the ACSTL, regulated parties are encouraged to select a device from the qualified technology section.

| Vendor | Device Model Number | Required Top Assembly Part Number | Material Discrimi- nation | # of Views | Capacity | Operating Voltage | Max Voltage | Date Qualified |
|--------------------|------------------------|---|---------------------------------|------------|-------------|----------------------|----------------|-------------------|
| Astrophysics Inc | VIC 100VDV | 00-13-1XDV-21 | Υ | Dual View | В | 165 kV | 180 kV | 10/22/2000 |
| Astrophysics, Inc. | XIS-100XDV | 00-23-1XDV-21 00-73-1XDV-11 | Y | | В | 165 KV | 180 KV | 10/23/2009 |
| | | 00-22-1XDX-11 | | | | | | |
| Astrophysics, Inc. | XIS-100XDX | 00-22-10DX-11 | Y | Dual View | В | 165 kV | 180 kV | 08/09/2012 |
| | | 00-03-1XDX-31 | 03-1XDX-31 | | | | | |
| | XIS-1517DV 200kV | 00-22-15DV-20 | Y | Dual View | С | 200 kV | 200 kV | 00/00/0040 |
| Astrophysics, Inc. | | 00-04-15DV-31 | | | | 200 KV | 200 KV | 08/09/2012 |
| Astrophysics, Inc. | XIS-1818DV 200kV | 00-22-18DV-20 | Y | Dual View | С | 200 kV | 200 kV | 08/09/2012 |
| Astrophysics, Inc. | XIS-1818DV | 00-00-18DV-23 | Υ | Dual View | Dual View C | 320 kV | 320 kV | 12/12/2012 |
| Astrophysics, inc. | 320kV | 00-05-18DV-31 | ı | Duai view | C | 320 KV | 320 KV | 12/12/2012 |
| Astrophysics, Inc. | XIS-6545DV | 00-13-6545DV-21 | Y | Dual View | Α | 165 kV | 180 kV | 10/23/2009 |
| Astrophysics, inc. | XI3-0343DV | 00-03-65DV-31 | | Dual View | _ ^ | | | 10/23/2009 |
| Astronhusias II | XIS-6545DVS | 00-30-6DVS-10 | Y | Dual View | А | 165 kV | 100 107 | 44/04/0040 |
| Astrophysics, Inc. | XIS-6545DVS | 00-03-6DVS-31 | Y | Duai view | A | IOSKV | 180 kV | 11/21/2016 |
| Astrophysics, Inc. | XIS-7858DVS | 00-30-7DVS-10 | Υ | Dual View | Α | 165 kV | 180 kV | 11/21/2016 |

| Vendor | Device Model Number | Required Top Assembly Part Number | Material Discrimi- nation | # of Views | Capacity | Operating Voltage | Max Voltage | Date Qualified |
|-------------------|------------------------|---|---------------------------------|---|----------|-------------------|----------------|-------------------|
| | | 00-73-7DVS-11 | | | | | | |
| Gilardoni S.p.A | FEP ME CARGO DV | 05141105 | Υ | Dual View | С | 200 kV | 300 kV | 11/05/2021 |
| Cilordoni C n A | FEP ME 640 | 05141182 | Y | Duel View | | 450 107 | 400147 | 04/40/2024 |
| Gilardoni S.p.A | AMX | 05141122 | T T | Dual view | A | 150 kV | 160kV | 01/12/2021 |
| Gilardoni, S.p.A. | FEP ME 755 AMX | 05141096 | Y | Dual View | Α | 150 kV | 160 kV | 10/23/2014 |
| Gilardoni S.p.A | FEP ME 1000 HC DV | 05141103 | Y | Dual View | В | 160 kV | 160kV | 01/12/2021 |
| Leidos (4) | ACX 6.4 MV | 1000-MV3AC-00 | Υ | Multi View | Α | 150 kV | 153 kV | 10/23/2009 |
| Leidos (4) | CX 6000 P DV | 002 | N | Dual View | С | 6MeV | 6MeV | 05/14/2010 |
| Leidos (4) | MVT-HR | 1000-10001-HR | Y | / Multi View | В | 150 kV | 160 kV | 02/03/2010 |
| Ecidos (4) | WIV T-TIIX | 1000-10002-HR | | Widia view | | 100 KV | 100 KV | 02/00/2010 |
| Leidos (4) | PX 10.10 MV | 1000-P1010-2V | Y | Dual View | В | 160 kV | 160 kV | 08/09/2012 |
| | | 1000-P1010-AC | | Dual View A Dual View B Multi View A Dual View C Multi View B | | | | |
| Leidos (4) | PX 15.17 MV 200kV | 0125-10732-00 | Y | Dual View | С | 200 kV | 200 kV | 08/09/2012 |
| Leidos (4) | PX 18.18 MV 200kV | 0125-10734-00 | Y | Dual View | С | 200 kV | 200 kV | 08/09/2012 |
| Leidos (4) | PX 18.18 MV 320kV | 0125-10735-00 | Y | Dual View | С | 320 kV | 320 kV | 12/12/2012 |
| Danissan Systems | 620DV | 2010001 | Y | Duel View | | 400 137 | 400.117 | 40/00/0000 |
| Rapiscan Systems | OZUDV | 2010002 | ĭ | Dual VIEW | , A | 160 kV | 180 kV | 10/23/2009 |

| Vendor | Device Model Number | Required Top Assembly Part Number | Material Discrimi- nation | # of Views | Capacity | Operating Voltage | Max Voltage | Date Qualified |
|---|-----------------------------|---|---------------------------------|------------|------------|--------------------------|---------------------------|-------------------|
| Rapiscan Systems (3) Rapiscan Systems | 627DV | 2010003 | Y | Dual View | 0 | 160 kV | 400 147 | 40/22/2000 |
| | 62700 | 2010004 |] Y | Dual view | В | 160 KV | 180 kV | 10/23/2009 |
| Rapiscan Systems | 628DV | 2010006 | Υ | Dual View | В | 160 kV | 180 kV | 05/14/2010 |
| Panisson Systems | 62201/ | 2010007 | | Dual View | 0 | 200 kV | 200 kV | 10/23/2009 |
| Kapiscan Systems | 632DV Y Dual View C 2010008 | | 200 KV | 200 KV | 10/23/2009 | | | |
| | | 2010009 | Y | Dual View | С | 200 kV | 200 kV | 10/23/2009 |
| Rapiscan Systems | 638DV | 2010010 | Y | Dual View | С | 320 kV | 320 kV | 06/23/2016 |
| Panisaan Systems | 920DX | 2010011 | Υ | Dual View | А | 160kV | 180kV | 01/22/2020 |
| Napiscan Systems | 92007 | 2010012 | ı | Duai view | A | TOURV | TOURV | 01/22/2020 |
| Raniscan Systems | 927DX | 2010026 | Y | Dual View | В | 160kV | 180kV | 01/22/2020 |
| rapiscan cystems | 327 BX | 2010027 | ' | Duai view | | TOOKV | 10000 | 01/22/2020 |
| Rapiscan Systems | 928DX | 2010028 | Y | Dual View | В | 160kV | 180kV | 01/22/2020 |
| rapiosan Systems | | 2010029 | | Budi View | | 10011 | 10011 | 01/22/2020 |
| Rapiscan Systems | 935DX | 2010025 | Y | Dual View | С | 240kV / 200 kV (2) | 300 kV / 200 kV (2) | 11/3/2022 |
| Rapiscan Systems | MVXR 5000 | 2010659-6 | Υ | Multi View | В | 170 kV | 180 kV | 02/03/2010 |
| | XR3D-6D | 500002-001 | Υ | Dual View | А | 160 kV | 160 KV | 10/24/2019 |
| | XR3D-7D | 500003-002 | Y | Dual View | А | 160 kV | 160 kV | 12/20/2019 |

| Vendor | Device Model Number | Required Top Assembly Part Number | Material Discrimi- nation | # of Views | Capacity | Operating Voltage | Max Voltage | Date Qualified |
|----------------------------|------------------------|---|---------------------------------|------------|----------|-------------------|----------------|-------------------|
| Rapiscan Systems (3) | XR3D-15D | 534307-109, Rev D and 535307-107, Rev F | Y | Dual View | С | 200 kV | 200 kV | 10/13/2021 |
| Rapiscan Systems (3) | XR3D-100D | 500068-001 | Υ | Dual View | В | 160 kV | 160kV | 12/20/2019 |
| Smiths Detection, Inc. | 6040-2is | HS 6040-2is | Υ | Dual View | Α | 160 kV | 180 kV | 08/27/2015 |
| Smiths Detection, Inc. | 6040aTiX | HS 6040aTiX | Υ | Dual View | Α | 160 kV | 176 kV | 10/23/2009 |
| Smiths Detection, Inc. | 6040aX | HS 6040aX | Υ | Dual View | Α | 160 kV | 176 kV | 08/09/2012 |
| Smiths Detection, Inc. | 7555aTiX | HS 7555aTiX | Υ | Dual View | Α | 160 kV | 176 kV | 05/14/2010 |
| Smiths Detection, Inc. | 7555aX | HS 7555aX | Υ | Dual View | Α | 160 kV | 176 kV | 08/09/2012 |
| Smiths Detection, Inc. | 10080 EdtS | HS 10080 EdtS | Y | Multi View | В | 160 kV | 176 kV | 10/23/2009 |
| Smiths Detection, Inc. | 10080 EDX-2is | HS 10080 EDX-2is (1132486) | Y | Dual View | В | 160 kV | 176 kV | 10/23/2009 |
| Smiths Detection, Inc. | 100100T-2is | HS 100100T-2is | Υ | Dual View | В | 160 kV | 176 kV | 10/23/2009 |
| Smiths Detection, Inc. | 100100V-2is | HS 100100V-2is 34504172 | Υ | Dual View | В | 160 kV | 176 kV | 08/09/2012 |
| Smiths Detection, Inc. | 130130T-2is | HS 130130T-2is | Υ | Dual View | В | 160 kV | 176 kV | 10/23/2009 |
| Smiths Detection, Inc. | 145180-2is | HS 145180-2is | Υ | Dual View | С | 160 kV | 176 kV | 4/25/2013 |
| Smiths Detection, Inc. | 180180-2is | HS 180180-300kV- 2is | N | Dual View | С | 300 kV | 320 kV | 10/23/2009 |
| Smiths Detection, Inc. | 180180-2is Pro | HS 180180-2is Pro | Υ | Dual View | С | 300 kV | 320 kV | 10/18/2016 |
| Smiths Detection, Inc. (1) | HRX 1000 DV | P0007033-011 | Y | Dual View | В | 165 kV | 180 kV | 05/14/2010 |
| Smiths Detection, Inc. | HS 145180-2is Pro | 11132774 | Y | Dual View | С | 200 kV | 220kV | 02/04/2021 |

| Vendor | Device Model Number | Required Top Assembly Part Number | Material Discrimi- nation | # of Views | Capacity | Operating Voltage | Max Voltage | Date Qualified |
|--------------------|---------------------------------|---|---------------------------------|------------|----------|-------------------|----------------|-------------------|
| VMI Security | Spectrum 180180DV (320kV) | 27.04.00389 | Y | Dual View | С | 310kV | 320kV | 09/10/2024 |
| VMI Security | Spectrum 6040DV | 27.04.00342 | Υ | Dual View | А | 170kV | 170kV | 09/10/2024 |
| VMI Security | Spectrum 100100HDV | 27.04.00377 | Υ | Dual View | В | 170kV | 170kV | 09/10/2024 |
| X-Ray Center (XRC) | XRC 60-40DV | XRC 60-40DV | Υ | Dual View | Α | 160 kV | 170 kV | 04/11/2018 |
| X-Ray Center (XRC) | XRC 75-55DV | XRC 75-55DV | Υ | Dual View | Α | 160 kV | 170 kV | 02/09/2021 |
| X-Ray Center (XRC) | XRC 100-100DV | XRC 100-100DV | Υ | Dual View | В | 165 kV | 180 KV | 05/23/2018 |
| X-Ray Center (XRC) | XRC 180-180DV (200kV) | XRC 180-180DV | Y | Dual View | С | 200 kV | 200 kV | 12/07/2021 |
| X-Ray Center (XRC) | XRC 100-100 HCDV | XRC 100-100 HCDV | Y | Dual View | С | 165kV | 180kV | 06/04/2024 |
| X-Ray Center (XRC) | XRC 180-180DV (320kV) | XRC 180-180DV | Υ | Dual View | С | 320 kV | 320 kV | 09/17/2019 |

- (1) Morpho Detection, Inc. was acquired by Smiths Detection, Inc. Either company's data plate is acceptable as long as the Top Assembly Part Number matches the number listed in the Qualified section.
- (2) Rapiscan 935DX Operating Voltage and Max Voltage reflect vertical / horizontal voltage.
- (3) VOTI Detection, Inc. was acquired by Rapiscan Systems. Either company's data plate is acceptable as long as the Top Assembly Part Number matches the number listed in the Qualified section.
- (4) L3 Security & Detection Systems was acquired by Leidos, either company's data plate is acceptable as long as the Top Assembly Part Number matches the number listed in the Qualified section.

2.2 Approved Visual Image Technology

The Approved Technology section specifies devices that have been conditionally approved for screening operations and are currently undergoing - or are scheduled for - field test activities. These devices have up to 36 months from the date added to the Approved Technology section to successfully pass TSA's suitability-based field test activities. If a device is unable to pass field test activities within the prescribed 36 months, it will be removed from the Approved Technology section. Due to this fact, regulated parties who procure a device from the Approved Technology section do so at their own risk. Additional technologies may be added to the list at TSA's discretion.

| Vendor | Device Model Number | Required Top Assembly Part Number | Material Discrimi- nation | # of Views | Capacity | Operating Voltage | Max Voltage | Date Approved |
|--------|------------------------|---|---------------------------------|---------------|----------|----------------------|----------------|------------------|
| | | | | | | | | |

2.3 Grandfathered Visual Image Technology

The Grandfathered Technology section specifies devices that are currently qualified to screen cargo but have a stated expiration date. This allows regulated parties who are using the grandfathered technology an opportunity to gradually phase out the device and transition to devices listed in the Qualified or Approved sections. Due to this fact, regulated parties should not purchase devices from this section; rather, they should reference the Qualified or Approved sections for their procurement needs.

Grandfathered Configurations for "hardware and software" are defined as the hardware configuration and any associated software version is grandfathered. Grandfathered Configurations for "software only" are defined as a particular software version is grandfathered; other Approved/Qualified software versions are available for this hardware configuration

| Vendor | Device Model Number | Required Top Assembly Part Number | Material Discrimi- nation | # of Views | Capacity | Operating Voltage | Max Voltage | Grandfathered Configuration | Expiration Date | | | | | |
|------------------|------------------------|---|---------------------------------|---------------|----------|----------------------|----------------|--------------------------------|--------------------|---|--------|--------|--|-------------|
| Paniagan Systems | 620DV | 620DVLHS- STND | | | Α | 160 kV | 180 kV | Hardware and Software | 12/31/2028 | | | | | |
| Rapiscan Systems | 020DV | 620DVRHS- STND | 1 | View | | 100 KV | 160 KV | | 12/31/2026 | | | | | |
| Rapiscan Systems | 62701/ | 627DV-STND | Y | Dual | В | 160 kV | 180 kV | Hardware and Software | 12/31/2028 | | | | | |
| Napiscan Systems | 627DV | 627DVE | Y | Y | Y | Y | Y | - Y | View | В | 100 KV | 100 KV | | 12/3 1/2020 |
| Rapiscan Systems | 628DV | 628DV-STND | Υ | Dual View | В | 160 kV | 180 kV | Hardware and Software | 12/31/2028 | | | | | |
| Rapiscan Systems | 632DV | 632DV200 | Y | Dual View | С | 200 kV | 200 kV | Hardware and Software | 12/31/2028 | | | | | |

| Vendor | Device Model Number | Required Top Assembly Part Number | Material Discrimi- nation | # of Views | Capacity | Operating Voltage | Max Voltage | Grandfathered Configuration | Expiration Date | |
|--------------------|------------------------|---|---------------------------------|---------------|----------|----------------------|----------------|--------------------------------|--------------------|------------|
| | | 632DV-STND | | | | | | | | |
| | | 632DVE | | | | | | | | |
| | | 638DV200 | | Dual | | | | Hardware and Software | | |
| Rapiscan Systems | 638DV | 638DV | 638DV-STND | Y | View | С | 200 kV | 200 kV | | 12/31/2028 |
| | | 638DV300 | Y | Dual View | С | 320 kV | 320 kV | Hardware and Software | 12/31/2028 | |
| | | 2010013 | | | В | | | | | |
| | | 2010014 | | Dual | | 160kV | 180kV | | | |
| Rapiscan Systems | 927DX | 2010015 | Y | | | | | Hardware and | 12/31/2041 | |
| . tap.oca Cyclomic | 02.27 | 2010016 | · | View | _ | 100 | l som | Software | , , | |
| | | 2010017 | | | | | | | | |
| | | 2010018 | | | | | | | | |
| | | 2010019 | | | | | | | | |
| | | 2010020 | | | | | | | | |
| Rapiscan Systems | 928DX | 2010021 | Y | Dual | В | 160kV | 180kV | Hardware and | 12/31/2041 | |
| | | 2010022 | | View | _ | | TOURV | Software | | |
| | | 2010023 | | | | | | | | |
| | | 2010024 | | | | | | | | |

3 Explosive Trace Detection (ETD) Devices

Technology Description: Desktop or handheld devices that detect explosive residual material on typical cargo substrates through the application and analysis of a swab-based collection process.

Refer to Appendix A, TSA's Trace Consumables List (TCL) for the TSA-approved third-party ETD Trace Consumables vendors.

3.1 Qualified ETD Technology

The Qualified Technology section specifies devices that have undergone a formal TSA-sponsored test process and are deemed qualified for screening operations. When procuring a device from the ACSTL, regulated parties are encouraged to select a device from the qualified technology section.

| Vendor (2) | Device Model Number | Required Top Assembly Part Number | Configuration Tested (1) | Date Qualified | |
|------------------------|------------------------|--------------------------------------|-----------------------------|----------------|--|
| Smiths Detection, Inc. | IONSCAN 600 | 4824000E-301-3 (3) | No Wand | 08/15/2023 | |
| Rapiscan Systems | Itemiser 5X (IT5X) | P0007018-018-CAR | No Wand | 08/15/2023 | |

- (1) Specification of "Wand" indicates a wand, also referred to as a hand-wand, is required to operate the device, to include all sampling, while the specification of "No Wand" indicates a wand must not be used to operate the device, to include all sampling which must be conducted by hand.
- (2) This model has a non-radioactive source thus annual radiation testing is not required.
- (3) The TAPN configuration for the IONSCAN 600 can be located on the bottom underneath the chassis.

3.2 Approved ETD Technology

The Approved Technology section specifies devices that have been conditionally approved for screening operations and are currently undergoing - or are scheduled for - field test activities. These devices have up to 36 months from the date added to the Approved Technology section to successfully pass TSA's suitability-based field test activities. If a device is unable to pass field test activities within the prescribed 36 months, it will be removed from the Approved Technology section. Due to this fact, regulated parties who procure a device from the Approved Technology section do so at their own risk. Additional technologies may be added to the list at TSA's discretion.

| Vendor | Device Model Number | Required Top Assembly Part Number | Configuration Tested (1) | Date Approved |
|------------------------|------------------------|--------------------------------------|-----------------------------|------------------|
| 1 st Detect | Tracer 1000 | 00-10001-04 | No Wand | 06/13/2024 |
| Bruker | DE-tector flex | 1880000T-TSA | No Wand | 08/08/2023 |

Notes:

(1) Specification of "Wand" indicates a wand, also referred to as a hand-wand, is required to operate the device, to include all sampling, while the specification of "No Wand" indicates a wand must not be used to operate the device, to include all sampling which must be conducted by hand.

3.3 Grandfathered ETD Technology

The Grandfathered Technology section specifies devices that are currently qualified to screen cargo but have a stated expiration date. This allows regulated parties who are using the grandfathered technology an opportunity to gradually phase out the device and transition to devices listed in the Qualified or Approved sections. Due to this fact, regulated parties should not purchase devices from this section; rather, they should reference the Qualified or Approved sections for their procurement needs.

Grandfathered Configurations for "hardware and software" are defined as the hardware configuration and any associated software version is grandfathered. Grandfathered Configurations for "software only" are defined as a particular software version is grandfathered; other Approved/Qualified software versions are available for this hardware configuration

| Vendor | Vendor Device Model Required Top Assembly Part Number | | Configuration Tested (1) | Grandfathered Configuration | Expiration Date |
|---------------------------|---|---|-----------------------------|--------------------------------|-----------------|
| Loidon (2) (2) | QS-B220 | 10011225 Rev. E, F, G, H, J, K, L, M, or N | No Wand | Hardware and Software | |
| Leidos (2) (3) | QS-B220 | QS-B220-001 Rev. A, B, C, D, or E | NO Wallu | | 12/31/2024 |
| Rapiscan | Itomicar DV | P0007018-014-CAR Rev. 2 | No Wand | Hardware and | 12/31/2024 |
| Systems (4) | Itemiser DX P0007018-014-CAR-R No Wand | | Software | 12/31/2024 | |
| Smiths Detection, Inc. | IONSCAN 500DT IONSCAN 500DT | | Wand/No Wand (6) | Hardware and Software | 12/31/2024 |

| Vendor | Device Model Number | Required Top Assembly Part Number | Configuration Tested (1) | Grandfathered Configuration | Expiration Date |
|-------------------------------|------------------------|--------------------------------------|-----------------------------|--------------------------------|-------------------|
| Smiths Detection, Inc. (2) | IONSCAN 600 | 4824000E-301-2 (8) | No Wand | Hardware and Software | 12/31/2024 (7) |

- (1) Specification of "Wand" indicates a wand, also referred to as a hand-wand, is required to operate the device, to include all sampling, while the specification of "No Wand" indicates a wand must not be used to operate the device, to include all sampling which must be conducted by hand.
- (2) This model has a non-radioactive source thus annual radiation testing is not required.
- (3) Implant Sciences Corporation was acquired by L3 Security & Detection Systems, now Leidos. Either company's data plate is acceptable as long as the Top Assembly Part Number matches the number listed in the Grandfathered section.
- (4) General Electric Homeland Protection was acquired by Morpho Detection; Morpho Detection's ETD business was subsequently acquired by Rapiscan Systems. All three companies' data plates are acceptable as long as the Top Assembly Part Number matches the number listed in the Grandfathered section.
- (5) The correct configuration will include Detection Parameters and one of the five software versions listed. TSA-AC-9822691-Alt Exp-RevB is the current version of the Detection Parameters.
- (6) This device can be used with or without a wand.
- (7) Extension of IONSCAN 600 4824000E-301-2 Expiration Date per Technical Bulletin 040.
- (8) The TAPN configuration for the IONSCAN 600 can be located on the bottom underneath the chassis.

4 Metal Detection (MD) Devices

Technology Description: Devices that interrogate items under inspection with a time varying electromagnetic field. Secondary magnetic disturbances induced by the primary field are detected by the MD, and an alarm condition is displayed if threshold levels have been exceeded.

Technology Classification: This technology is classified by three designations: type, class, and capacity (see below for descriptions). Although a device can only be classified into one type and capacity, it can be qualified for more than one class.

| | Type Designations | | | | | | | | | |
|---------|---|--|--|--|--|--|--|--|--|--|
| ID | Description | | | | | | | | | |
| Type I | Type I General Detection Capability – Capable of detecting threats without any indication of threat location. | | | | | | | | | |
| Type II | Detection Plus Localizing Capability – Capable of detecting threats and providing visual cues for the location of detected threats. | | | | | | | | | |

| 1 | | Class Designations | | | | | | | | | | |
|-------|---------------------------|---|--|--|--|--|--|--|--|--|--|--|
| ID | Description | Examples | | | | | | | | | | |
| 1 | Printed Matter (PM) | Newspapers, Books, Magazines, Flyers. | | | | | | | | | | |
| 2 (1) | Electronic Equipment (EE) | Digital Clocks, Sandwich Makers, Blow Dryers, Computers, Personal Digital Assistants. | | | | | | | | | | |
| 3 (1) | Machine Parts (MP) | Auto Parts, Aircraft Starters, Car Jacks, Food Graters. | | | | | | | | | | |
| 4 (1) | Misc. Durable Goods (MDG) | Home Renovation Materials, Canned Goods, Furniture. | | | | | | | | | | |
| 5 | Wearing Apparel (WA) | Clothing, Shoes, Handbags, Jackets. | | | | | | | | | | |
| 6 | Fresh Produce (FP) | Grapefruit, Pineapple, Cucumbers. | | | | | | | | | | |
| 7 | Fresh Flowers (FF) | Various Tubers and Bulbs, Annual and Perennial Flowers, Cut Flowers. | | | | | | | | | | |
| 8 | Fish and Meats (FM) | Shrimp, Fish, Beef, Poultry. | | | | | | | | | | |

Notes:

(1) These commodity classes are expected to contain trace or significant amounts of metallic materials, and hence are not suitable for metal screening.

| | Capacity Designations (1) | | | | | | | | |
|--|---|--|--|--|--|--|--|--|--|
| ID Description | | | | | | | | | |
| Small Aperture – Can accommodate screening of air cargo with an item size of at least 49 cm (19.3 cm (15 in.) high by 91 cm (35.8 in.) long and 50 kg (110.2 lbs.) in weight and up to 80 cm (31.5 in.) v (23.6 in.) high by 120 cm (47.2 in.) long and 100 kg (220.5 lbs.) in weight. | | | | | | | | | |
| В | Medium Aperture – Can accommodate screening of air cargo with an item size of at least 80 cm (31.5 in.) wide by 60 cm (23.6 in.) high by 120 cm (47.2 in.) long and 100 kg (220.5 lbs.) in weight and up to 122 cm (48 in.) wide by 153 cm (60.2 in.) high by 122 cm (48 in.) long and 1,000 kg (2,205 lbs.) in weight. | | | | | | | | |
| С | Large Aperture – Can accommodate screening of air cargo with an item size of at least 122 cm (48 in.) wide by 153 cm (60.2 in.) high by 122 cm (48 in.) long and 1,000 kg (2,205 lbs.) in weight. | | | | | | | | |

Notes:

(1) The capacity listing is for testing and informational purposes only.

4.1 Qualified MD Technology

The Qualified Technology section specifies devices that have undergone a formal TSA-sponsored test process and are deemed qualified for screening operations. When procuring a device from the ACSTL, regulated parties are encouraged to select a device from the qualified technology section.

| Vendor | Device Model Number | Required Top Assembly Part Number | Class 1 (PM) | Class 5 (WA) | Class 6 (FP) | Class 7 (FF) | | Туре | Capacity | Date Qualified |
|-------------------|------------------------|---|-----------------|-----------------|-----------------|-----------------|-----|------|------------|-------------------|
| CEIA USA (2) EMIS | EMIS 6047 | EMIS6047 | YES | YES | YES | YES | YES | | Α | 03/13/2013 |
| CEIA USA (2) | EMIS 0047 | EMIS_6047_001 | 163 163 | ILS | 123 | 123 | ı | A | 03/13/2013 | |
| | | EMIS8075 | | | | | | | | |
| CEIA USA (2) | EMIS 8075 | EMIS_8075_001 | YES | YES | YES | YES YES | YES | ı | В | 03/13/2013 |
| | | EMIS_8075_002 | | | | | | | | |
| CEIA USA (2) | EMIS 110160 | EMIS_110160_001 | YES | YES | YES | YES | YES | I | В | 03/13/2013 |
| CEIA USA (2) | EMIS 130160 | EMIS_130160_001 | NO | NO | YES | YES | YES | I | С | 03/13/2013 |
| CEIA USA (2) | EMIS 130200 | EMIS_130200_002 | YES | YES | YES | YES | YES | I | С | 05/10/2018 |

- (1) "YES" indicates the commodity classes for which each EMD device passed Stage I testing. "NO" indicates the commodity classes for which each EMD device did not pass Stage I testing.
- (2) CEIA models must contain all three software components listed.

4.2 Approved MD Technology

The Approved Technology section specifies devices that have been conditionally approved for screening operations and are currently undergoing - or are scheduled for - field test activities. These devices have up to 36 months from the date added to the Approved Technology section to successfully pass TSA's suitability-based field test activities. If a device is unable to pass field test activities within the prescribed 36 months, it will be removed from the Approved Technology section. Due to this fact, regulated parties who procure a device from the Approved Technology section do so at their own risk. Additional technologies may be added to the list at TSA's discretion.

There are currently no systems in the Approved MD Technology section.

| Vendor | Device Model Number | Required Top Assembly Part Number | Class 1 (PM) | Class 5 (WA) | Class 6 (FP) | Class 7 (FF) | Class 8 (FM) | Туре | Capacity | Date Approved |
|--------|------------------------|---|-----------------|-----------------|-----------------|-----------------|-----------------|------|----------|------------------|
| | | | | | | | | | | |

4.3 Grandfathered MD Technology

The Grandfathered Technology section specifies devices that are currently qualified to screen cargo but have a stated expiration date. This allows regulated parties who are using the grandfathered technology an opportunity to gradually phase out the device and transition to devices listed in the Qualified or Approved sections. Due to this fact, regulated parties should not purchase devices from this section; rather, they should reference the Qualified or Approved sections for their procurement needs.

Grandfathered Configurations for "hardware and software" are defined as the hardware configuration and any associated software version is grandfathered. Grandfathered Configurations for "software only" are defined as a particular software version is grandfathered; other Approved/Qualified software versions are available for this hardware configuration

| Vendor | Device Model Number | Required Top Assembly Part Number | Class 1 (PM) | Class 5 (WA) | Class 6 (FP) | Class 7 (FF) | Class 8 (FM) | Туре | Capacity | Grandfathered Configuration | Expiration Date |
|-------------------------|---------------------------|---|-----------------|-----------------|-----------------|-----------------|-----------------|------|----------|--------------------------------|--------------------|
| Mettler-Toledo Safeline | SL 2000 A | 176Y7692 | YES | YES | YES | YES | YES | ı | А | Hardware and Software | 06/13/2025 |
| Mettler-Toledo Safeline | SL 2000 B | 176W7692 | YES | YES | YES | YES | YES | I | В | Hardware and Software | 06/13/2025 |

Notes:

(1) "YES" indicates the commodity classes for which each MD device passed Stage I testing. "NO" indicates the commodity classes for which each EMD device did not pass Stage I testing.

5 Explosive Detection Systems (EDS)

Technology Description: Devices that use computed tomography and sophisticated algorithms to automatically detect explosive materials.

5.1 Qualified EDS Technology

The Qualified Technology section specifies devices that have undergone a formal TSA-sponsored test process and are deemed qualified for screening operations. When procuring a device from the ACSTL, regulated parties are encouraged to select a device from the qualified technology section.

| Vendor | Device Model Number | Required Top Assembly Part Number | Date Qualified |
|------------------|---------------------|--------------------------------------|----------------|
| Rapiscan Systems | RTT110 | RTT110-TSA | 04/02/2024 |

5.2 Approved EDS Technology

The Approved Technology section specifies devices that have been conditionally approved for screening operations and are currently undergoing - or are scheduled for - field test activities. These devices have up to 36 months from the date added to the Approved Technology section to successfully pass TSA's suitability-based field test activities. If a device is unable to pass field test activities within the prescribed 36 months, it will be removed from the Approved Technology section. Due to this fact, regulated parties who procure a device from the Approved Technology section do so at their own risk. Additional technologies may be added to the list at TSA's discretion.

| Vendor | Device Model Number | Required Top Assembly Part Number | Date Approved |
|------------------------|---------------------|---|-------------------|
| Smiths Detection, Inc. | HS 10080 XCT | 34453300 | 01/19/2022 (1) |

Notes:

(1) Smiths Detection, Inc. HS 10080 XCT extended to 07/19/2025 per Technical Bulletin 043, EDS Technology Approval Extension.

5.3 Grandfathered EDS Technology

The Grandfathered Technology section specifies devices that are currently qualified to screen cargo but have a stated expiration date. This allows regulated parties who are using the grandfathered technology an opportunity to gradually phase out the device and transition to devices listed in the Qualified or Approved sections. Due to this fact, regulated parties should not purchase devices from this section; rather, they should reference the Qualified or Approved sections for their procurement needs.

Grandfathered Configurations for "hardware and software" are defined as the hardware configuration and any associated software version is grandfathered. Grandfathered Configurations for "software only" are defined as a particular software version is grandfathered; other Approved/Qualified software versions are available for this hardware configuration

There are currently no systems in the Grandfathered EDS Technology section

| Vendor | Device Model Number | Required Top Assembly Part Number | Grandfathered Configuration | Expiration Date |
|--------|------------------------|---|--------------------------------|--------------------|
| | | | | |

6 Carbon Dioxide (CO2) Monitors

Technology Description: Handheld or portable devices that collect air samples and evaluate the concentration of carbon dioxide to detect the presence of a concealed human in a tendered cargo item.

6.1 Qualified CO2 Monitor Technology

The Qualified Technology section specifies devices that have undergone a formal TSA-sponsored test process and are deemed qualified for screening operations. When procuring a device from the ACSTL, regulated parties are encouraged to select a device from the qualified technology section.

There are currently no systems in the Qualified CO2 Monitor Technology section.

| Vendor | Device Model Number | Required Top Assembly Part Number | Date Qualified |
|--------|---------------------|-----------------------------------|----------------|
| | | | |

6.2 Approved CO2 Monitor Technology

The Approved Technology section specifies devices that have been conditionally approved for screening operations and are currently undergoing - or are scheduled for - field test activities. These devices have up to 36 months from the date added to the Approved Technology section to successfully pass TSA's suitability-based field test activities. If a device is unable to pass field test activities within the prescribed 36 months, it will be removed from the Approved Technology section. Due to this fact, regulated parties who procure a device from the Approved Technology section do so at their own risk. Additional technologies may be added to the list at TSA's discretion.

There are currently no systems in the Approved CO2 Monitor Technology section.

| Vendor | Device Model Number | Required Top Assembly Part Number | Date Approved |
|--------|---------------------|-----------------------------------|---------------|
| | | | |

6.3 Grandfathered CO2 Monitor Technology

The Grandfathered Technology section specifies devices that are currently qualified to screen cargo but have a stated expiration date. This allows regulated parties who are using the grandfathered technology an opportunity to gradually phase out the device and transition to devices listed in the Qualified or Approved sections. Due to this fact, regulated parties should not purchase devices from this section; rather, they should reference the Qualified or Approved sections for their procurement needs.

Grandfathered Configurations for "hardware and software" are defined as the hardware configuration and any associated software version is grandfathered. Grandfathered Configurations for "software only" are defined as a particular software version is grandfathered; other Approved/Qualified software versions are available for this hardware configuration

| Vendor | Device Model Number | Required Top Assembly Part Number | Grandfathered Configuration | Expiration Date |
|----------------------|---------------------|--------------------------------------|--------------------------------|-----------------|
| Armstrong Monitoring | AMC-CD-2 | AMC-CD-2 | Hardware and Software | 12/31/2025 |
| InstroTek, Inc. | Guard 1 | 1010000 | Hardware and Software | 12/31/2025 |

Appendix A: Trace Consumables

To ensure that Explosive Trace Detection (ETD) units operate at a level of maximum effectiveness in detecting explosives, TSA requires that all consumables purchased for screening air cargo either appear on the Trace Consumables List (TCL) or be supplied by the manufacturer of the ETD device. TSA expresses no preference for manufacturer-supplied consumables or for third-party-supplied consumables.

The TCL identifies third-party ETD consumable items tested by TSA and found to have comparable performance to similar type consumables supplied by the security system manufacturers. Third party consumable items not on the TCL either did not pass the TSA evaluation or were not tested by TSA.

Third-Party Consumables Vendors

Contact information for vendors appearing in the TCL is listed below in alphabetical order.

| Company | Address | Phone | Website |
|---------------------------------|--|----------------------------------|---------------------------------------|
| DSA Detection | 120 Water Street, Suite 211 N. Andover, MA 01845 | (978) 975-3200 | www.dsadetection.com |
| ETD Direct, LLC | 1121 Route 34, Suite N-404 Aberdeen, NJ 07747 | (908) 614-7835 | www.etddirect.com |
| Microsilver Wear, Inc. | 601 Route 206, Suite 26-330 Hillsborough, NJ 08844 | (908) 698-4421 | www.microsilverinc.com |
| Princeton Security Technologies | 2925 State Road Croydon, PA 19021-6960 | (609) 915-9700 (215) 458-4181 | www.princetonsecuritytechnologies.com |
| US Testing Equipment, LTD | 7201 NE 18 th St., Suite A Vancouver, WA 98661 | (888) 687-8378 | www.ustesting.com |

Trace Consumables List

| Model | Manufacturer | Item Description | Part Number | Supplier |
|------------------|------------------|---|-----------------------------|---------------------------------|
| IONSCAN 500DT | Smiths Detection | Condenser Tube Kit with Gaskets | DCK7658 | DSA Detection |
| IONSCAN 500DT | Smiths Detection | Condenser Tube | DCT6686 | DSA Detection |
| IONSCAN 500DT | Smiths Detection | Hand Swab (200ct) | DSW1210P | DSA Detection |
| IONSCAN 500DT | Smiths Detection | Hand Swab (200ct) | 500DT – Manual or SD1201 | ETD Direct |
| IONSCAN 500DT | Smiths Detection | Hand Swab (200ct) | Manual/DT | Microsilver |
| IONSCAN 500DT | Smiths Detection | Printer Paper | DPP8047 | DSA Detection |
| IONSCAN 500DT | Smiths Detection | Printer Ribbon | DPR4728 | DSA Detection |
| IONSCAN 500DT | Smiths Detection | Sample Swab 500DT (200ct) | Swab/DT | Microsilver |
| IONSCAN 500DT | Smiths Detection | Sample Swab (200ct) | TDT000500DT | US Testing Equipment, LTD |
| IONSCAN 500DT | Smiths Detection | Sample Swab, Nomex | PST-N101 | Princeton Security Technologies |
| IONSCAN 500DT | Smiths Detection | Sample Swab, 500DT (200ct) | DSW8055P | DSA Detection |
| IONSCAN 500DT | Smiths Detection | Verification Pen, 500DT | DVP1883 | DSA Detection |
| IONSCAN 500DT | Smiths Detection | Verification Pen | DTV-Pen or SD3203 | ETD Direct |
| IONSCAN 500DT | Smiths Detection | Veri-Tek Pen | PST VT-101 | Princeton Security Technologies |
| Itemiser 5X | Rapiscan Systems | Assy, Dopant, Ammonium Carbamate, G-CAL, In Packaging | 101018182 | US Testing Equipment, LTD |
| Itemiser 5X | Rapiscan Systems | Assy, Dopant, Dichloromethane, G-CAL, In Packaging | 101018180 | US Testing Equipment, LTD |
| Itemiser 5X | Rapiscan Systems | Assy, Dopant, Toluene, G-CAL, In Packaging | 101018184 | US Testing Equipment, LTD |
| Itemiser 5X | Rapiscan Systems | Assy, HV Lamp Extraction Tool, IT 4DX | M1000365 | US Testing Equipment, LTD |

| Model | Manufacturer | Item Description | Part Number | Supplier |
|-------------|------------------|--|--------------|---------------------------|
| Itemiser 5X | Rapiscan Systems | Assy, Single Flow Meter, Itemiser 5X | 101032440 | US Testing Equipment, LTD |
| Itemiser 5X | Rapiscan Systems | Calibrant, Internal, Methyl Salicylate | MP100973 | US Testing Equipment, LTD |
| Itemiser 5x | Rapiscan Systems | Calibration Traps (100ct) | MD1965-100 | ETD- Direct |
| Itemiser 5X | Rapiscan Systems | Filter Element, In-Line Air Filter, 12MMX8MMX20MML | MP101671 | US Testing Equipment, LTD |
| Itemiser 5X | Rapiscan Systems | Flow Meter | M0001931 | US Testing Equipment, LTD |
| Itemiser 5X | Rapiscan Systems | Kit, Lamps, Itemiser 5X | K1000200 | US Testing Equipment, LTD |
| Itemiser 5X | Rapiscan Systems | Product Accessory, Nozzle Screen Kit, Itemiser 5X | PA005379 | US Testing Equipment, LTD |
| Itemiser 5x | Rapiscan Systems | Sample Swabs (100ct) | MD1964 | ETD- Direct |
| Itemiser 5x | Rapiscan Systems | Verification Traps (100ct) | MD1966-100 | ETD- Direct |
| Itemiser DX | Rapiscan Systems | 5 Micron Filter | FE3224 | DSA Detection |
| Itemiser DX | Rapiscan Systems | 5 Micron Filter | MP003244 | US Testing Equipment, LTD |
| Itemiser DX | Rapiscan Systems | 50ct Individually Wrapped Isopropyl Wipes | MP075037 | US Testing Equipment, LTD |
| Itemiser DX | Rapiscan Systems | 50ct Individually Wrapped Isopropyl Wipes | SW7507 | DSA Detection |
| Itemiser DX | Rapiscan Systems | Bumper Feet | BF1702 | DSA Detection |
| Itemiser DX | Rapiscan Systems | Bumper Feet | MP017022 | US Testing Equipment, LTD |
| Itemiser DX | Rapiscan Systems | Calibration Traps (100ct), Multi-purpose | CT1319P | DSA Detection |
| Itemiser DX | Rapiscan Systems | Calibration Traps (100ct) | MD-1965-100 | ETD Direct |
| Itemiser DX | Rapiscan Systems | Calibration Traps (25ct), Multi-purpose | CT1317P | DSA Detection |
| Itemiser DX | Rapiscan Systems | Calibration Traps (Teflon) 100ct | M0001964-100 | US Testing Equipment, LTD |
| Itemiser DX | Rapiscan Systems | Calibration Traps (Teflon) 25ct | M0001964-25 | US Testing Equipment, LTD |
| Itemiser DX | Rapiscan Systems | Calibration Traps (100ct) | MD1965-100 | ETD- Direct |
| Itemiser DX | Rapiscan Systems | Canned Air | CA7503 | DSA Detection |
| Itemiser DX | Rapiscan Systems | Canned Air | MP075003 | US Testing Equipment, LTD |
| Itemiser DX | Rapiscan Systems | Chemical, Positive Dopant, Ammonia, Crystal, 5-Mo Life | MP035087 | US Testing Equipment, LTD |
| Itemiser DX | Rapiscan Systems | Clearing Spray | CS1831 | DSA Detection |
| Itemiser DX | Rapiscan Systems | Clearing Spray | M0001831 | US Testing Equipment, LTD |
| Itemiser DX | Rapiscan Systems | Clearing Spray | MD1831 | ETD Direct |
| Itemiser DX | Rapiscan Systems | Cotton Gloves (12/pack) | GL7500 | DSA Detection |

| Model | Manufacturer | Item Description | Part Number | Supplier |
|-------------|------------------|---|-------------|---------------------------|
| Itemiser DX | Rapiscan Systems | Cotton Gloves (12/pack) | MP075000 | US Testing Equipment, LTD |
| Itemiser DX | Rapiscan Systems | Dopant, Explosives (1/Instrument) | MP005810 | US Testing Equipment, LTD |
| Itemiser DX | Rapiscan Systems | E-Mode Dopant (Permeation Device) | D5810 | DSA Detection |
| Itemiser DX | Rapiscan Systems | Fan Filter Guard | FG7125 | DSA Detection |
| Itemiser DX | Rapiscan Systems | Fan Filter Guard | MP007125 | US Testing Equipment, LTD |
| Itemiser DX | Rapiscan Systems | Filter, Sintered 316 SS (with FW9556) | MP003223 | US Testing Equipment, LTD |
| Itemiser DX | Rapiscan Systems | Filter, Sintered 316 SS (with FW9556) | SF3223 | DSA Detection |
| Itemiser DX | Rapiscan Systems | Foam Filter | FF3222 | DSA Detection |
| Itemiser DX | Rapiscan Systems | Foam Filter | MP003222 | US Testing Equipment, LTD |
| Itemiser DX | Rapiscan Systems | Fuse, 3.15V, Type T | EP002500 | US Testing Equipment, LTD |
| Itemiser DX | Rapiscan Systems | Fuse, 3.15V, Type T | FS2500 | DSA Detection |
| Itemiser DX | Rapiscan Systems | Fuse 15A, 32V, 3AG for DC input | EP002525 | US Testing Equipment, LTD |
| Itemiser DX | Rapiscan Systems | Fuse 15A, 32V, 3AG f or DC input | FS2525 | DSA Detection |
| Itemiser DX | Rapiscan Systems | Maintenance Kit | MK5286 | DSA Detection |
| Itemiser DX | Rapiscan Systems | Maintenance Kit | PA005286 | US Testing Equipment, LTD |
| Itemiser DX | Rapiscan Systems | Membrane Tool Probe Stick | MP055226 | US Testing Equipment, LTD |
| Itemiser DX | Rapiscan Systems | Membrane Tool Probe Stick | MS5226 | DSA Detection |
| Itemiser DX | Rapiscan Systems | Narcotics, Long Life Dopant | D5087 | DSA Detection |
| Itemiser DX | Rapiscan Systems | Nozzle Screen Kit, Itemiser DX | NK5282 | DSA Detection |
| Itemiser DX | Rapiscan Systems | Nozzle Screen Kit, Itemiser DX | PA005282 | US Testing Equipment, LTD |
| Itemiser DX | Rapiscan Systems | O-Ring, Size 11, KALREZ Compound 4079, Duro | MP011191 | US Testing Equipment, LTD |
| Itemiser DX | Rapiscan Systems | O-Ring, Size 11, KALREZ Compound 4079, Duro | OR1191 | DSA Detection |
| Itemiser DX | Rapiscan Systems | O-Ring .176 ID | MP011008 | US Testing Equipment, LTD |
| Itemiser DX | Rapiscan Systems | O-Ring .176 ID | OR1108 | DSA Detection |
| Itemiser DX | Rapiscan Systems | PTFE Tubing | MP008043 | US Testing Equipment, LTD |
| Itemiser DX | Rapiscan Systems | PTFE Tubing | TU8043 | DSA Detection |
| Itemiser DX | Rapiscan Systems | Sample Swabs (100ct) | Multi/DX | Microsilver |
| Itemiser DX | Rapiscan Systems | Sample Swabs (100ct) | TRAPDX | Microsilver |

| Model | Manufacturer | Item Description | Part Number | Supplier |
|-------------|------------------|---|-------------------|---------------------------|
| Itemiser DX | Rapiscan Systems | Sample Swabs (100ct) | DX-Swab or MD1964 | ETD Direct |
| Itemiser DX | Rapiscan Systems | Sample Swabs High Performance (100ct) | M0002057 | US Testing Equipment, LTD |
| Itemiser DX | Rapiscan Systems | Sample Traps (100ct), Multi-purpose | ST1318P | DSA Detection |
| Itemiser DX | Rapiscan Systems | Sample Traps (25ct), Multi-purpose | ST1316P | DSA Detection |
| Itemiser DX | Rapiscan Systems | Sample Traps (Teflon) 100ct | M0001965-100 | US Testing Equipment, LTD |
| Itemiser DX | Rapiscan Systems | Sample Traps (Teflon) 25ct | M0001965-25 | US Testing Equipment, LTD |
| Itemiser DX | Rapiscan Systems | Saturated Swabs | MP075002 | US Testing Equipment, LTD |
| Itemiser DX | Rapiscan Systems | Saturated Swabs | SS7502 | DSA Detection |
| Itemiser DX | Rapiscan Systems | Saturated Wipes | MP075001 | US Testing Equipment, LTD |
| Itemiser DX | Rapiscan Systems | Saturated Wipes | SW7501 | US Testing Equipment, LTD |
| Itemiser DX | Rapiscan Systems | Silastic Tubing | MP008047 | US Testing Equipment, LTD |
| Itemiser DX | Rapiscan Systems | Silastic Tubing | TU8047 | DSA Detection |
| Itemiser DX | Rapiscan Systems | Spare Kit | PA005254 | US Testing Equipment, LTD |
| Itemiser DX | Rapiscan Systems | Spare Kit | SK5284 | DSA Detection |
| Itemiser DX | Rapiscan Systems | Thermal Printer Paper Roll | PA005060 | US Testing Equipment, LTD |
| Itemiser DX | Rapiscan Systems | Thermal Printer Paper Roll | PP5060 | DSA Detection |
| Itemiser DX | Rapiscan Systems | Verification Traps (100ct) | VT1336P | DSA Detection |
| Itemiser DX | Rapiscan Systems | Verification Traps (100ct) | MD-1966-100 | ETD Direct |
| Itemiser DX | Rapiscan Systems | Verification Traps (25ct) | VT1337P | DSA Detection |
| Itemiser DX | Rapiscan Systems | Verification Traps (Teflon) 100ct | M0001966-100 | US Testing Equipment, LTD |
| Itemiser DX | Rapiscan Systems | Verification Traps (Teflon) 25ct | M0001966-25 | US Testing Equipment, LTD |
| Itemiser DX | Rapiscan Systems | Verification Traps (100ct) | MD1966-100 | ETD Direct |
| QS B220 | Leidos | Calibration Trap | CT1272 | DSA Detection |
| QS B220 | Leidos | Calibration Trap | IS1272-25 | ETD Direct |
| QS B220 | Leidos | Dual Mode Verification Swab (A Negative and B Positive) | VT1272 | DSA Detection |
| QS B220 | Leidos | Molecular Sieve Canister | BSC1329 | DSA Detection |
| QS B220 | Leidos | Positive Verification Tin | BSB1035 | DSA Detection |
| QS B220 | Leidos | Sample Swabs (100ct) | ST1269P | DSA Detection |

| Model | Manufacturer | Item Description | Part Number | Supplier |
|---------|--------------|---|------------------|---------------|
| QS B220 | Leidos | Sample Swabs | IS1000-100 Rev E | ETD Direct |
| QS B220 | Leidos | Sample Swabs (100ct) | SWB/220 | Microsilver |
| QS B220 | Leidos | Sample Trap | ST1269 | DSA Detection |
| QS B220 | Leidos | Sieve Canister, QS-B220 | MSC-220 | Microsilver |
| QS B220 | Leidos | Sieve Canister, single | IS1329 | ETD Direct |
| QS B220 | Leidos | Sieve Canister, 4 pack | IS0023 | ETD Direct |
| QS B220 | Leidos | Verification Pen Kit, A (Neg) and B (Pos) | ISV1482PK | ETD Direct |
| QS B220 | Leidos | Verification Pen, Sample A (Neg) | ISV0156P | ETD Direct |
| QS B220 | Leidos | Verification Pen, Sample B (Pos) | ISV1326P | ETD Direct |
| QS B220 | Leidos | Verification Sample A (Negative) | BSA1030 | DSA Detection |
| QS B220 | Leidos | Verification Sample A, Negative mode | VSA/N | Microsilver |
| QS B220 | Leidos | Verification Sample B, Positive mode | VSB/P | Microsilver |